

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/580,526	<b>Applicant(s)/Patent under Reexamination</b> NICASTRO, FRANCESCO
<b>Examiner</b> Sean P. Shechtman	<b>Art Unit</b> 2125	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner